

IEW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Leonel R. Arana et al.	§	Group Art Unit:
Serial No.:	10/807,836	§	Examiner:
Filed:	March 24, 2004	§	Atty. Dkt. No.:
For:	Microfabricated Hot Wire Vacuum Sensor	§	ITL.1133US (P19113)
		§	Assignee:
		§	Intel Corporation

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

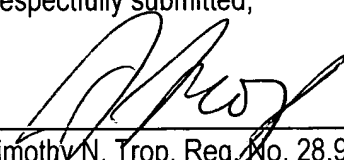
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicant submits the references listed on the attached form PTO 1449, copies of which are enclosed. A copy of a communication dated August 1, 2005 from a foreign patent office in a counterpart application is also enclosed. I, the undersigned, hereby certify that each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. Please apply any charges or credits to Deposit Account No. 20-1504 (ITL.1133US).

Respectfully submitted,

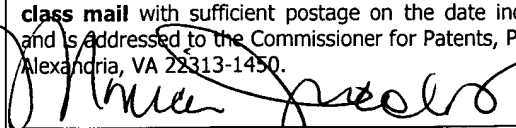
August 4, 2005
Date

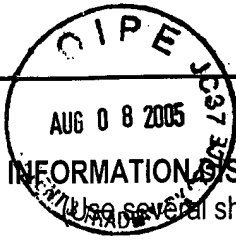


Timothy N. Trop, Reg. No. 28,994
Trop, Pruner & Hu, P.C.
8554 Katy Freeway, Ste. 100
Houston, TX 77024
713/468-8880
713/468-8883 [fax]

Attorney for Intel Corporation

Customer No. 21906

Date of Deposit: <u>August 4, 2005</u> I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated above and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.  _____ Monica Jacobs



INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

*ATTY DOCKET NO. ITL.1133US (P19113)	SERIAL NO. 10/807,836
APPLICANT(S): Leonel R. Arana et al.	
FILING DATE: March 24, 2004	GROUP ART UNIT:

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
A.	6,553,841	04/29/2003	Blouch			
B.						
C.						
D.						
E.						

U.S. PATENT APPLICATION PUBLICATIONS

F.	2003/0073292	04/17/2003	Bartlett et al.			
G.						
H.						
I.						
J.						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
K.	DE 43 24 119	01/27/1994	Germany				X
L.	DE 100 49 556	06/13/2001	Germany				X
M.	DE 199 03 010	08/17/2000	Germany				X
N.	JP 63-284835	11/22/1988	Japan			Abstract Only	
O.	JP 2001-324403	11/22/2001	Japan			Abstract Only	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

P.	
Q.	
R.	
S.	
T.	
U.	
V.	

EXAMINER	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.